



# An easily prepared carbon quantum dots and employment for inverted organic photovoltaic devices



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## HIGHLIGHTS

- Dual electron transporting layer is used in organic solar cells.
- The energy barrier for electron transport is decreased.
- The balanced charge transfer of electron and hole is achieved.
- Well contact of active layer and cathode is realized.
- Electron extraction improvement by a good energy levels tailorment.

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## ABSTRACT

In this paper, the performance enhancement of organic solar cells based on PCDTBT:PC<sub>71</sub>BM and P3HT:PC<sub>60</sub>BM are demonstrated via employing carbon quantum dots (CQD) to modify the metal oxide electron transport layer. The incorporated CQD with carboxylic acid (–COOH) groups could induce self-assembled monolayer (SAM) with TiO<sub>2</sub> buffer layer, which lowered the energy barrier for electron transfer and reduced the inherent incompatibility between the metal oxide and organic active layers. Further investigation shows that SAM of TiO<sub>2</sub> with CQD can improve the photo-induced exciton dissociation and charge transfer, leading to a low electron accumulation in charge transport layer and a reduced interface recombination loss.

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## 1. Introduction

High efficiency organic bulk-heterojunction (BHJ) photovoltaics (OPVs) have been intensive studied because of low cost fabrication, facile processing methods, and portable energy source compared with Si-based inorganic solar cells [1,2]. Upon using new designed low bandgap polymers, controlling the active layer microstructure, and optimizing the device structure, the power conversion efficiency (PCE) of OPVs has been increased to more than 10% [3–7]. For practical applications, the inverted structure OPV (I-OPV), usually owns a metal oxide (such as TiO<sub>x</sub>, ZnO) electron buffer layer (EBL) on ITO glass and high work function metal (Ag) as anode, which can improve air stability and manufacturing compatibility

[8–14]. However, I-OPVs are still suffering from relatively lower PCE to meet the commercialization, possibly because the electrons are trapped on the interface between the active layer and the metallic oxide buffer layer, which are caused by the EBL surface defects as well as electron loss from slow charge injection due to the mismatch of work functions (WF) [15–18].

Several semiconductor materials have been used as the cathode interlayer for I-OPVs to lower the barrier of electron transfer from active layer to the ITO electrode. Among which titanium oxide (TiO<sub>2</sub>) is one of the most extensively investigated to enhance the electron collection at the cathode for high efficiency and air-stable solar cells [19,20]. TiO<sub>2</sub> prepared by a simple sol–gel method is provided to be a multifunctional buffer layer including oxygen barrier, an optical spacer, and a hole blocking layer due to its merits of high electron affinity, high transparency, and excellent electrical/optical properties [21,22]. Nevertheless, the sol–gel EBLs still

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suffer from some inadequacies, such as sensitive to moisture and the pin-holes introduced by thermal treatment lessen the blocking process, which are responsible for the loss of electron collection. The oxygen vacancies exist in  $\text{TiO}_2$  film, which are energetically deep trap levels, inducing a severe recombination loss [23–26]. Moreover, a key limitation for high efficiency cells is that the electrical properties of the  $\text{TiO}_2$  films are strongly related to the processing conditions. Therefore, the electron transport and collection may be less effective in  $\text{TiO}_2$  buffer layer, and the highest reported electron mobility is  $1.7 \times 10^{-4} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ , which is still lower than that of polymer photo-layer and results in electron accumulation [27–30]. For these reasons, many efforts have been made to facilitate efficient electron transport, enhancing electro-conductibility and suppressing trap-assisted recombination. For example, noble metal nanoparticles and quantum dots (QDs) materials have been used to dope into metal oxide and modify EBL surface with self-assembled monolayer (SAM) [31–36]. The SAM method provides a unique shortcut to regulate the physical and chemical properties of underlying substrate surfaces. On one hand, the SAM can adjust the surface energies and properties of underlying materials, which could promote the interfacial adhesion between the metal oxide EBL and the adjoining polymer photo-layer [37–40]. On the other hand, the SAM can not only affect the electrical property but also tailor band alignment of the underlying film, and thus enhance charge transfer [41].

In this study, we prepared carbon quantum dots (CQD) by a facile way and capped it on the sol–gel  $\text{TiO}_2$  as the combined electron transport layer (ETL) for I-OPVs. Compared with conventional semiconductor QDs, CQD with the virtues of similar fluorescence properties, excellent electrical conductivity, low cost, ease of synthesis, and low toxicity in addition to photochemical and chemical stability are employed to effectively modify EBL [42,43]. As the most popular materials, Poly [*N*-9'-hepta-decanyl-2,7-carbazole-alt-5,5'-(4',7'-di-2-thienyl-2',1',3'-benzothiadiazole)]:[6,6]-phenyl  $\text{C}_{71}$ -butyric acid methyl ester (PCDTBT:PC<sub>71</sub>BM) and poly(3-hexylthiophene-2,5-diyl):[6,6]-phenyl  $\text{C}_{60}$ -butyric acid methyl ester (P3HT:PC<sub>60</sub>BM) are used as the BHJ active layer in I-OPVs system. Herein, we demonstrated a possible mechanism to explain the relation between EBL components, surface morphology, charge carrier transport properties, and electrical contact with photo-to-electrical energy conversion process. By applying a SAM  $\text{TiO}_2$ /CQD as EBL, the short-circuit current ( $J_{sc}$ ) and fill factor (FF) are both increased and achieved a higher PCE, and thus proposes an attractive strategy for realizing roll-to-roll, high efficiency, and commercially available solar cell production.

## 2. Experimental

### 2.1. CQD Preparation and property

The microwave synthesis of CQD follows procedures given in our previous work [44,45]. A sample of the CQD was diluted in aqueous solution, which was purified in a centrifuge (10,000 r/min, 20 min) to remove large or agglomerated particles, and the sizes of left CQD are in the range from 1 to 5 nm. The schematic molecule structure of CQD is exhibited in Fig. 1a, and the substituent group of SAM that has great affinity to the surface –OH of  $\text{TiO}_2$ . CQD can be bound on the surface with –COOH group anchored surface with Ti–OH groups to form a carboxylate bond and the other one oriented towards vacuum.

### 2.2. Device fabrication and characterization

The devices were made with the structure of indium tin oxide (ITO)/titanium dioxide ( $\text{TiO}_2$ )/active layer/molybdenum oxide

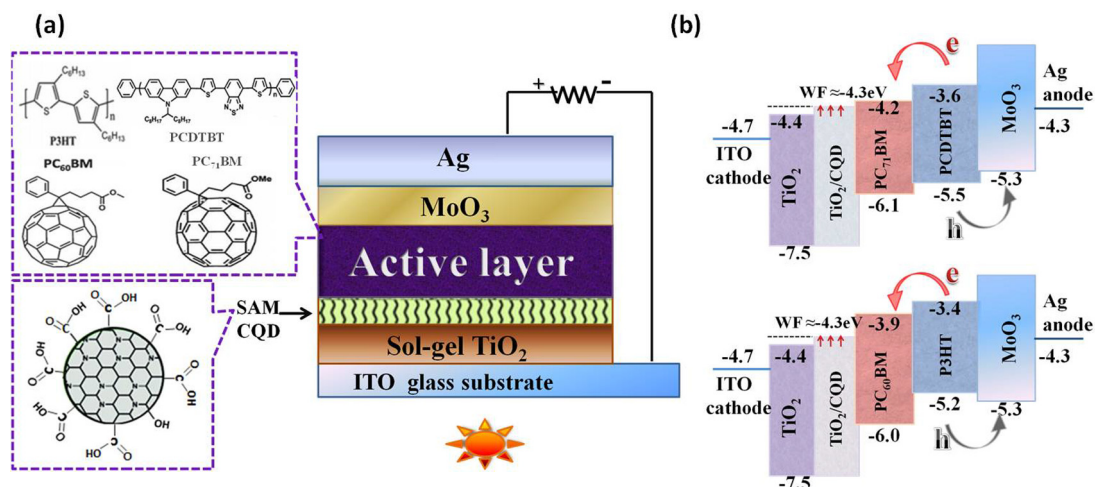
( $\text{MoO}_3$ )/silver (Ag), and the energy levels of all used materials are also shown in Fig. 1b. The patterned ITO-coated glass substrates were washed by acetone, anhydrous alcohol, and deionized water in sequence and subsequently dried with nitrogen. Anatase- $\text{TiO}_2$  layer (thickness of 40 nm) was prepared on the cleaned substrates using sol–gel method. For the control devices, the active layers (100 nm) of PCDTBT:PC<sub>71</sub>BM and P3HT:PC<sub>60</sub>BM were spin-coated on top of pristine  $\text{TiO}_2$  films and annealed for 20 min in glove box and named Device I and Device II, respectively. While for the optimal devices, in order to form a SAM layer, the substrates with  $\text{TiO}_2$  films were first immersed into the low concentration aqueous alkaline solution for 6 h. Then, the prepared CQD solutions with different concentrations of 1.2, 2.8, and 4.0 mg/mL were spin-coated on the top of hydroxylation processed  $\text{TiO}_2$  with 5 min thermal treatment at 100 °C. The detailed process of SAM is demonstrated in Fig. 3. The active films were forming on different concentrations of CQD modified EBLs under the same condition with control devices. These cells with structure of ITO/ $\text{TiO}_2$ /CQD/active layer/ $\text{MoO}_3$ /Ag are named as Device A, B, and C for PCDTBT system, and Device D, E, and F for P3HT system, respectively. Furthermore, in order to facilitate comparison, the devices with structure of ITO/ $\text{TiO}_2$ /CQD/active layer/ $\text{MoO}_3$ /Ag were made with CQD directly spin-coating on  $\text{TiO}_2$  film without SAM process and the corresponding cells are named as Device a, b, c, d, e, and f accordingly. Finally, the OPVs were finished by thermal evaporation of 4 nm  $\text{MoO}_3$  and 100 nm Ag as a hole transport layer (HTL) and electrode without encapsulation. All the other experimental parameters were based on previous experience. The active area of the device was about 0.064  $\text{cm}^2$ .

Atomic Force Microscope (AFM) images in tapping mode were carried out using a Veeco multimode with a nanoscope III controller. Current density–voltage (J–V) characteristics of the finished devices were measured using a computer-programmed Keithley 2400 source/meter under AM 1.5G solar illuminations with an Oriel 300 W solar simulator intensity of  $\sim 100 \text{ mW cm}^{-2}$  (about one sun) in air. The light intensity was measured with a photometer (International light, IL1400) corrected by a standard silicon solar cell. The incident photon-to-current efficiency (IPCE) was measured with Crowntech QTest Station 1000 AD. The absorption and transmittance spectra were measured by means of ultraviolet/visible spectrometer (UV 1700, Shimadzu).

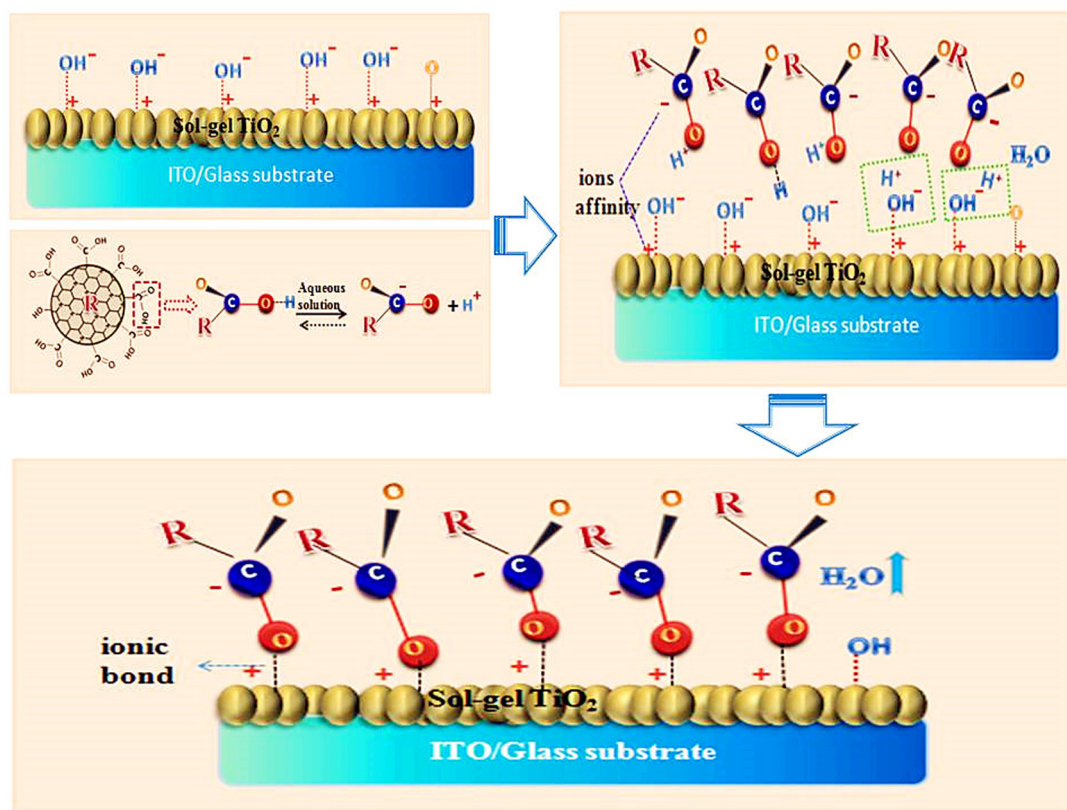
## 3. Results and discussion

As shown in Fig. 2, the SAM processes including three steps in our experiment (I) The hydroxylate of  $\text{TiO}_2$ , in which the –OH or O (oxygen atom) will facilitate adsorbed onto the film surface, and Ti (Titanium atom) will has a positive charge ( $\text{M}^+$ ). (II) The neutralization reaction of strong Lewis acidic and alkali. Carboxyl groups with a negative charge caused by ionization will ionic bond with the  $\text{M}^+$  firmly and the ionized  $\text{H}^+$  will integrate the –OH or O resulted into –OH or  $\text{H}_2\text{O}$ . (III) Electrostatic interaction leads to an immediate and uniform formation of strong dipoles matrix pointing toward the surface of  $\text{TiO}_2$  induced by electron-withdrawing terminal functional group of SAM [46–48]. Employing a thin SAM CQD interlayer can induce an interfacial dipole and thereby reduce the work function (WF) of ETL in theory. More importantly, Carboxylic-acid linkages tend to be more stable than  $-\text{NH}_2$  (ammonium groups) and –OH bonds under wet conditions. Even under dry condition, the pressure of 10–12 atmosphere are required to reduce a full monolayer to half coverage, which was investigated by Moreira [49].

The interaction between the oxide and organic materials is immensely vital in dominating the surface property and interfacial



**Fig. 1.** (a) Schematic representation of I-OPVs structure and molecular structures of materials involved in this study. (b) Energy level diagram in I-OPVs based on PCDTBT:PC<sub>71</sub>BM and P3HT:PC<sub>60</sub>BM active layer.



**Fig. 2.** (I) Hydroxylation process of TiO<sub>2</sub> film; Protonation of -COOH group suspended on CQD molecule, (II) Self-assembly of CQD deposition on TiO<sub>2</sub> film surface, (III) TiO<sub>2</sub>/SAM CQD films.

energy-level alignment. At the initial of our study, Kelvin probe system was carried out to obtain the work functions (WF) of ETL surface. The recorded values of WF were 4.42 eV and 4.31 eV for TiO<sub>2</sub> and TiO<sub>2</sub>/CQD respectively. For desired electron transport, the lowest unoccupied molecular orbital (LUMO) level of the acceptor material should be basically flat to the WF of the ETL. Therefore, the WF of TiO<sub>2</sub>/CQD perfectly links up the LUMO of acceptor and TiO<sub>2</sub> ETLs, the electrons transport from active layer to the cathode is implemented with low energy barriers, resulting in a fast electron extraction.

As is well-known, surface wetting is an important factor for the solution coating process, and the water contact angles (WCA) of TiO<sub>2</sub> and TiO<sub>2</sub>/CQD surface were measured. It can be seen in Fig. 3 that water droplets on TiO<sub>2</sub>, TiO<sub>2</sub>/CQD(non-SAM), and TiO<sub>2</sub>/CQD(SAM) show the contact angles ( $\theta$ ) of 26.86°, 29.38°, and 42.16°, respectively. Both SAM TiO<sub>2</sub>/CQD and non-SAM TiO<sub>2</sub>/CQD surfaces exhibit an increased WCA than pristine TiO<sub>2</sub>, indicating the well distributed CQD could be responsible for poor wetting. The incorporation of CQD by SAM process makes it more hydrophobic than pure TiO<sub>2</sub>, which is beneficial for the





Fig. 3. Contact angles of the water-drops on the surface of (a) bare  $\text{TiO}_2$ , (b)  $\text{TiO}_2/\text{non-SAM CQD}$ , and (c)  $\text{TiO}_2/\text{SAM CQD}$  films.

spin-coating of active layer solution, leading to a better adhesion and filming property between metallic oxide ETL and organic photo-layer.

The illuminated J–V characteristics of the OPVs with or without CQD coated layer by SAM or non-SAM process are exhibited in Fig. 4. For the OPVs with PCDTBT:PC<sub>71</sub>BM active layer, the control device I without modification has a  $J_{sc}$  of  $13.76 \text{ mA cm}^{-2}$ ,  $V_{oc}$  of 0.85 V, FF of 52.04%, yielding a PCE of 6.12%. For the devices with P3HT:PC<sub>60</sub>BM active layer, the control device II owns a  $J_{sc}$  of  $13.01 \text{ mA cm}^{-2}$ ,  $V_{oc}$  of 0.58 V, FF of 49.11%, leading to a PCE of 3.73% in Fig. 4c. The performance of modified cells is improved at variety degrees mainly due to the enhancement of  $J_{sc}$  and FF while keeping  $V_{oc}$  in value. The cells with two different active layers own the highest efficiency with 2.8 mg/mL CQD solution modified  $\text{TiO}_2$  no matter by SAM or non-SAM process, which are presented in Fig. 4b and d. Under the optimal concentration, the devices with a SAM modifier showed a better  $J_{sc}$  and FF compared to that with

simply spin-coated CQD. The PCEs of Device B and E (SAM) are increased to 7.33% and 4.42%, accounting to a 19.77% and 18.50% enhancement. However, the PCEs of Device b and e (non-SAM) are increased to 6.87% and 4.10%, leading to 12.25% and 9.63% enhancement compared to control Device I and Device II. All the photovoltaic parameters of OPVs in this work are summarized in Tables 1 and 2 associated with PCDTBT and P3HT active layer, which are the average of 24 devices for every kind I-OPVs. Device A–F based on  $\text{TiO}_2/\text{CQD}(\text{SAM})$  ETL show better performance improvement than Device a–f based on non-SAM CQD modified  $\text{TiO}_2$  in particular on FF. Through calculating the slopes of the J–V curves, a relatively lower series resistance ( $R_s$ ) with increased sharply shunt resistance ( $R_{sh}$ ) was confirmed in the presence of the CQD. The  $R_s$  of OPVs stands for the resistance of the semiconductor bulk, the metal electrodes, and the metal/semiconductor interfaces. Correspondingly,  $R_{sh}$  basically illustrates the recombination of charge carriers at the interface and near electrodes [50]. The

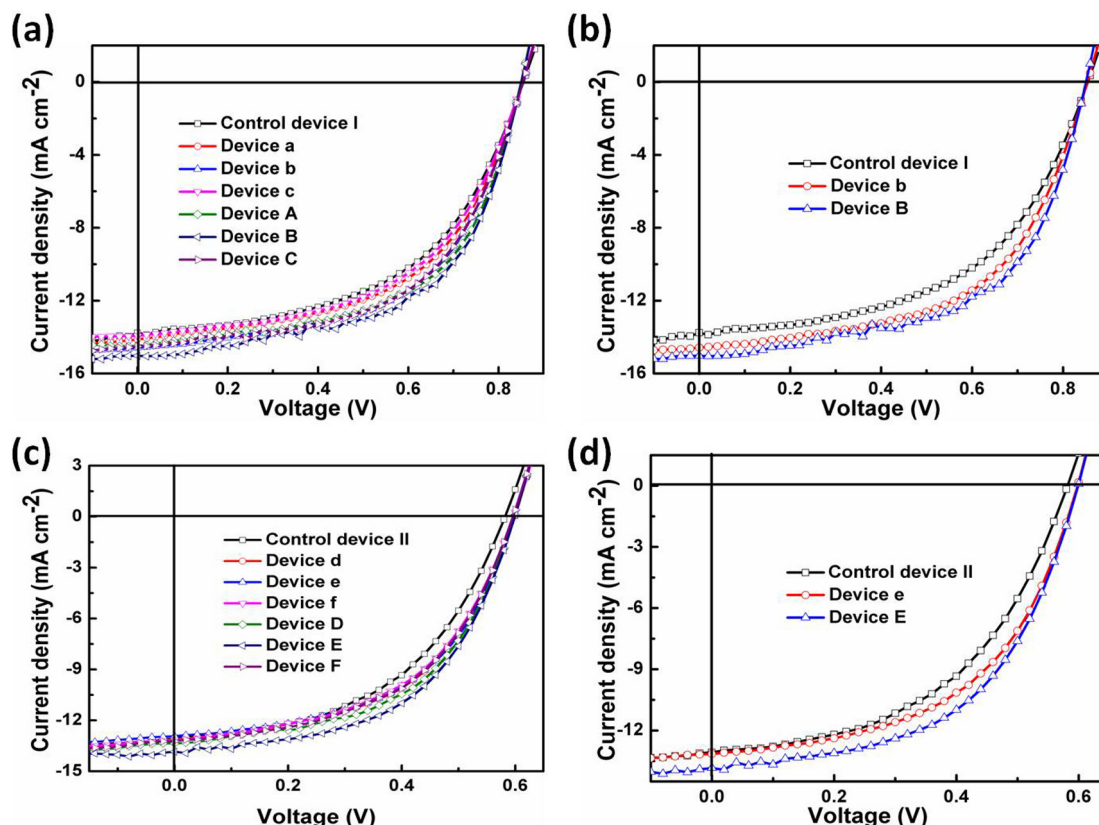


Fig. 4. The J–V characteristics of (a) control device, CQD modified cells with different concentration of 1.2 mg/mL, 2.8 mg/mL, and 4.0 mg/mL (Device a–c: non-SAM CQD, Device A–C: SAM CQD) based on PCDTBT active layer. (b) I-OPVs without and with optimized concentration of CQD modification by non-SAM and SAM process based on PCDTBT active layer. (c) Control device, CQD modified cells with different concentration of 1.2 mg/mL, 2.8 mg/mL, and 4.0 mg/mL (Device d–f: non-SAM CQD, Device D–F: SAM CQD) based on P3HT active layer. (d) I-OPVs without and with optimized concentration of CQD modification by non-SAM and SAM process based on P3HT active layer.

**Table 1**

Characteristics of PCDTBT:PC<sub>71</sub>BM I-OPVs based on TiO<sub>2</sub>, TiO<sub>2</sub>/non-SAM CQD (Device a–c) and TiO<sub>2</sub>/SAM CQD (Device A–C) as electron transport layer (ETL) with different concentration of 1.2 mg/mL, 2.8 mg/mL, and 4.0 mg/mL CQD.

Device	V <sub>oc</sub> (V)	J <sub>sc</sub> (mA cm <sup>-2</sup> )	FF (%)	PCE (%)	R <sub>s</sub> (Ω)	R <sub>sh</sub> (Ω)
I	0.85 ± 0.02	13.76 ± 0.13	52.04 ± 0.01	6.12 ± 0.11	234.31	2522.4
a	0.85 ± 0.04	14.13 ± 0.11	53.58 ± 0.03	6.46 ± 0.11	189.80	6524.2
b	0.85 ± 0.02	14.58 ± 0.09	55.23 ± 0.03	6.87 ± 0.09	169.87	6229.7
c	0.85 ± 0.05	13.93 ± 0.12	52.95 ± 0.04	6.29 ± 0.13	191.97	8033.7
A	0.85 ± 0.02	14.48 ± 0.09	56.60 ± 0.02	6.97 ± 0.11	158.82	12365.0
B	0.85 ± 0.01	15.02 ± 0.08	57.36 ± 0.02	7.33 ± 0.12	145.32	21301.6
C	0.85 ± 0.03	14.51 ± 0.12	55.35 ± 0.01	6.86 ± 0.13	161.96	9277.3

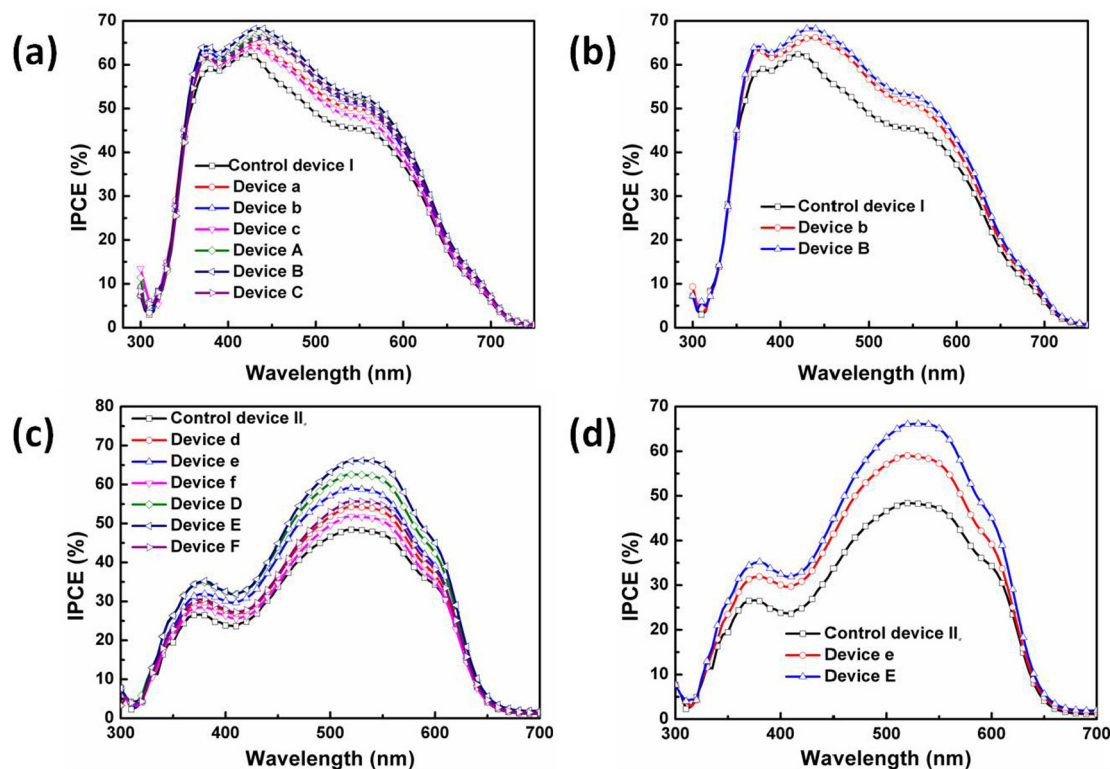
**Table 2**

Characteristics of P3HT:PC<sub>60</sub>BM I-OPVs based on TiO<sub>2</sub>, TiO<sub>2</sub>/non-SAM CQD (Device d–f) and TiO<sub>2</sub>/SAM CQD (Device D–F) as ETL with different concentration of 1.2 mg/mL, 2.8 mg/mL, and 4.0 mg/mL CQD.

Device	V <sub>oc</sub> (V)	J <sub>sc</sub> (mA cm <sup>-2</sup> )	FF (%)	PCE (%)	R <sub>s</sub> (Ω)	R <sub>sh</sub> (Ω)
II	0.58 ± 0.03	13.01 ± 0.13	49.11 ± 0.02	3.73 ± 0.12	165.71	4633.4
d	0.59 ± 0.02	13.13 ± 0.11	51.41 ± 0.03	4.05 ± 0.13	145.02	5994.2
e	0.59 ± 0.03	13.15 ± 0.11	52.17 ± 0.02	4.10 ± 0.10	142.94	7367.0
f	0.59 ± 0.04	13.17 ± 0.07	50.70 ± 0.05	3.99 ± 0.12	156.97	7288.9
D	0.59 ± 0.04	13.36 ± 0.09	52.94 ± 0.02	4.24 ± 0.09	140.17	17639.7
E	0.59 ± 0.02	13.84 ± 0.09	53.35 ± 0.03	4.42 ± 0.13	136.46	14569.0
F	0.59 ± 0.04	13.22 ± 0.10	51.38 ± 0.02	4.05 ± 0.11	141.81	6631.7

R<sub>s</sub> was progressively decreased with CQD incorporation, especially for the case of SAM modified with 2.8 mg/mL CQD, which could be attributed to the enhanced charge carrier transport ability along TiO<sub>2</sub>/CQD. This low electronic resistivity will facilitate charge carriers to transport from the bulk heterojunction composite to the respective electrodes. As a consequence, the inserted SAM CQD can effectively depress bulk recombination and reduce interfacial resistance, which accounts for FF increase of 8.22% and 8.63% for the best device with PCDTBT and P3HT system respectively. Due to the lower charge transfer and contact resistance, a larger elec-

tron extraction driving force can result in a larger J<sub>sc</sub>. Furthermore, we have tried to modify TiO<sub>2</sub> buffer layer by just depositing thermally evaporated C<sub>60</sub>. As results, the optimal devices show a little higher performance than control devices, but not as good as the devices modified with SAM process. Moreover, the evaporation process is more inconvenience and higher cost than the SAM process. The J–V characteristics and IPCE curves of control devices, devices with evaporated C<sub>60</sub>, and SAM modified devices are shown in Fig. S1 (Supporting Information), and all the performance data are summarized in Table S1 (Supporting Information).

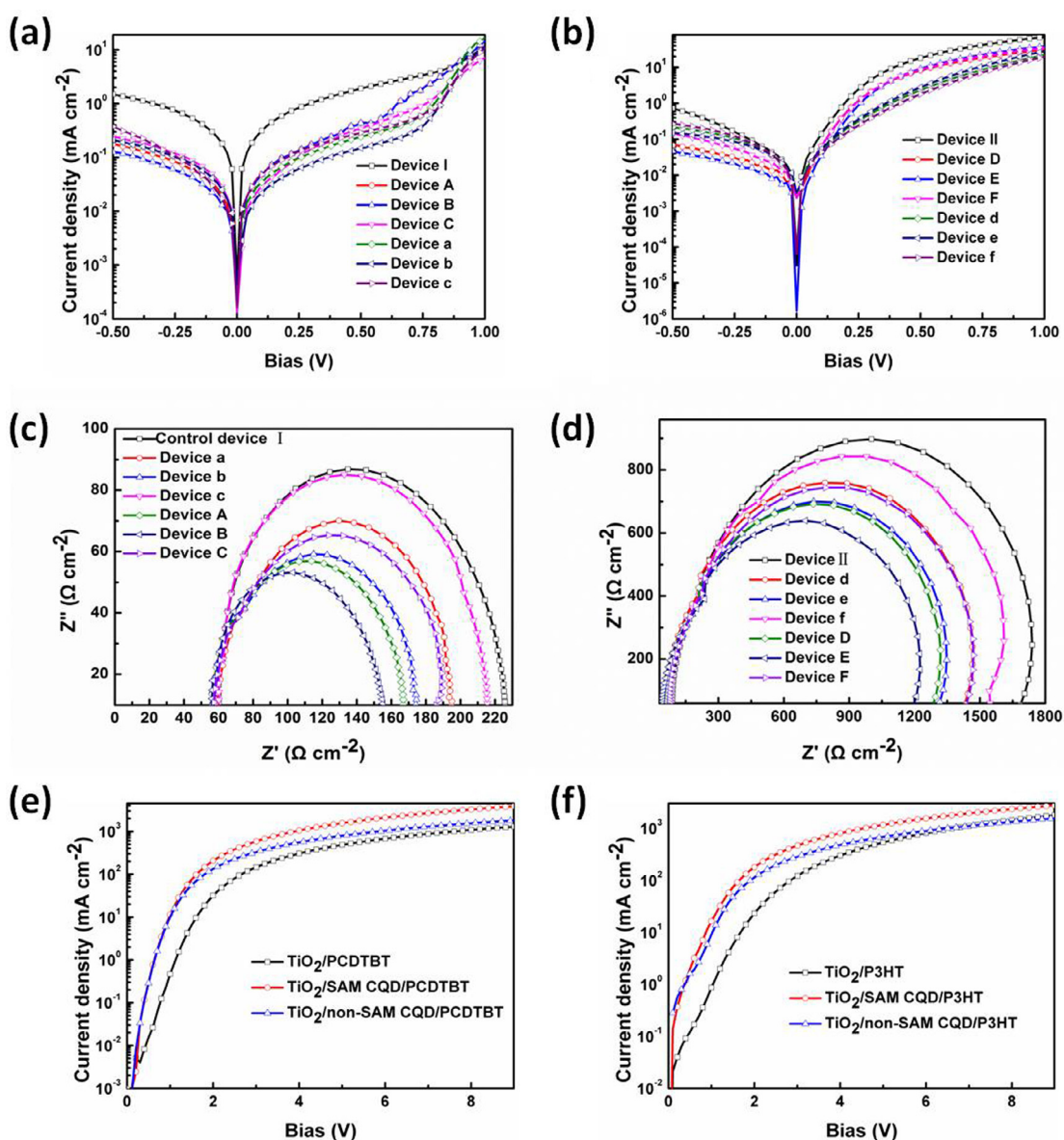


**Fig. 5.** IPCE spectrum of (a) control device, non-SAM CQD modified cells (devices a–c) and SAM CQD modified cells (device A–C) based on PCDTBT active layer. (b) Devices with TiO<sub>2</sub>, TiO<sub>2</sub>/non-SAM CQD, and TiO<sub>2</sub>/SAM CQD as ETL with optimized concentration of CQD (2.8 mg/mL) for PCDTBT active layer. (c) Control device, non-SAM CQD modified cells (devices d–f) and SAM CQDs modified cells (device D–F) with CQD based on P3HT active layer. (d) Devices with TiO<sub>2</sub>, TiO<sub>2</sub>/non-SAM CQD, and TiO<sub>2</sub>/SAM CQD as ETL with optimized concentration of CQD (2.8 mg/mL) for P3HT active layer.

Therefore, it can be concluded that the SAM CQD modified OPVs present the best device performance because of the optimization of EBL surface energy and morphology, which resulted in the best contact with the active layer on top. The simple spin-coated process of modifier leads to the formation of particulate clusters rather than well arranged CQD, which may contribute to the insufficient interfacial adhesion with photo-layer as well as a discontinuous electron transport through the clusters, thus the performance of Device a-f (non-SAM) are inferior good. In addition, the concentration of CQD increased over 4.0 mg/mL, the PCEs of devices were slightly declined, which may be ascribed to the reduced light absorption of active layer and SAM interface properties.

To deeply understand the mechanism of  $J_{sc}$  improvement, the IPCE spectra of the devices were indicated in Fig. 5. Both IPCE of two kinds of modified devices are higher than that of control device over the almost entire wavelength range, especially from 350 nm to 625 nm, and the dependence of IPCE data on the

concentrations of CQD are in good agreement with J-V characteristics. It is worth pointing out that the devices with  $TiO_2$ /CQD (SAM) ETL show the highest IPCE values, following by the devices with composite  $TiO_2$ /CQD(non-SAM) and the reference devices. For the devices with PCDTBT as electron donor (Fig. 5b), the IPCE of global optimum device B shows the maximum of ~68% around 440 nm, which is higher than that of the control device I (~60% at 420 nm). For the devices with P3HT:PC<sub>60</sub>BM as active layer (Fig. 5d), the IPCE of the reference device II shows a maximum of ~46%, while the IPCE of the optimal device E with a SAM ETL is the maximum value of ~67% around 525 nm, which is also much higher than that of the control device. The largest improvement of IPCE values for two different active layer compounds were observed in the wavelength range where the reference device showed the highest IPCE, which indicates that the charge transport capacity enhancement of the devices with SAM CQD and non-SAM CQD effectively prevented carrier recombination,



**Fig. 6.** The J-V characteristics of devices without and with different concentration of CQD modification by non-SAM and SAM process based on (a) PCDTBT:PC<sub>71</sub>BM and (b) P3HT:PC<sub>60</sub>BM active layer in dark. Nyquist plots of impedance spectra for OPVs based on (c) PCDTBT:PC<sub>71</sub>BM and (d) P3HT:PC<sub>60</sub>BM without and with different concentration of CQD by non-SAM and SAM method in dark. J-V characteristics of electron-only devices without and with 2.8 mg/mL CQD modification by non-SAM and SAM process for (e) PCDTBT:PC<sub>71</sub>BM and (f) P3HT:PC<sub>60</sub>BM active layer respectively. These data unraveled an excrescent shunt resistance ( $R_{sh}$ ) and a smaller series or contact resistance ( $R_c$ ) was obtained in SAM modified devices, implying that the EBL interface became more suited for electron transport and hole blocking, resulting in the increased FF and photocurrent. Moreover, the device under bias also showed larger injection current compared with the control device, which could prevent the current from leakage.



especially in the case of high photo-generated carriers [51–54]. Thereby, this observation provides a direct evidence for the increase of  $J_{sc}$ .

The dark J–V curves for all fabricated OPVs were presented in Fig. 6a and b. The devices A–F with  $\text{TiO}_2/\text{CQD}(\text{SAM})$  exhibit excellent diode property and suppressed leakage current under reverse bias condition compared to the devices based on  $\text{TiO}_2/\text{CQD}(\text{non-SAM})$  and pristine  $\text{TiO}_2$ .

To probe into the effect of SAM CQD on the electron transport and recombination, electrochemical impedance spectroscopy (EIS) of all the devices was tested under open circuit voltage condition from the frequency of 20 Hz to 20 MHz and shown in Fig. 6c and d. The semicircle's diameter in the Nyquist plots stands for the impedance values, which depends on charge transport at the interface between the photo-layer and electrode in the low-frequency region. Though Devices b and e with  $\text{TiO}_2/\text{CQD}(\text{non-SAM})$  EBL exhibit slightly lower charge transfer resistance than the control Device I and Device II, the modification with a SAM CQD leads to a significant decline to impedance of device B and E, which presents a better interface was formed by introducing a SAM CQD coated layer. Thus, the injection barrier of electron was decreased, which effectively facilitated electron transfer from the active layer to cathode [55]. CQD with special structure could serve

as a superfast bridge to facilitate the electron delivery, and thus refrained recombination loss from charge accumulation.

To verify the role of CQD on the electron mobility, the electron-only devices were fabricated with the structure of  $\text{ITO}/\text{TiO}_2/\text{active layer}/\text{MoO}_3/\text{Ag}$ ,  $\text{ITO}/\text{TiO}_2/\text{CQD}(\text{SAM})/\text{active layer}/\text{MoO}_3/\text{Ag}$ , and  $\text{ITO}/\text{TiO}_2/\text{CQD}(\text{non-SAM})/\text{active layer}/\text{MoO}_3/\text{Ag}$ , respectively. The electron mobility was determined by fitting the dark current to the space charge limited current (SCLC) method [56]. As shown in Fig. 6e and f, the bare  $\text{TiO}_2$  based device exhibited the relatively lower electron mobilities ( $\mu_e$ ) of  $7.23 \times 10^{-5} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$  and  $6.46 \times 10^{-5} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$  for PCDTBT and P3HT donors. After simply spin-coating CQD on  $\text{TiO}_2$ , the electron mobilities mildly increased to  $6.22 \times 10^{-4} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$  and  $5.33 \times 10^{-4} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$  respectively, which is credited to the fabulous nature electrical conductive property of CQD. Coupled with an excellent interlayer surface, the SAM CQD inserted devices displayed the highest electron mobilities of  $8.43 \times 10^{-4} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$  and  $8.22 \times 10^{-4} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ , which guaranteed a high mobility level of ETL at the same degree with active layer, and thus a more balance and unblocked charge carriers transport were achieved. As a consequence, an apparent increase of electron mobility leads to a more quickly migration of charge carrier and space charge formation decrease, resulting in the highest  $J_{sc}$  for SAM CQD based OPVs.

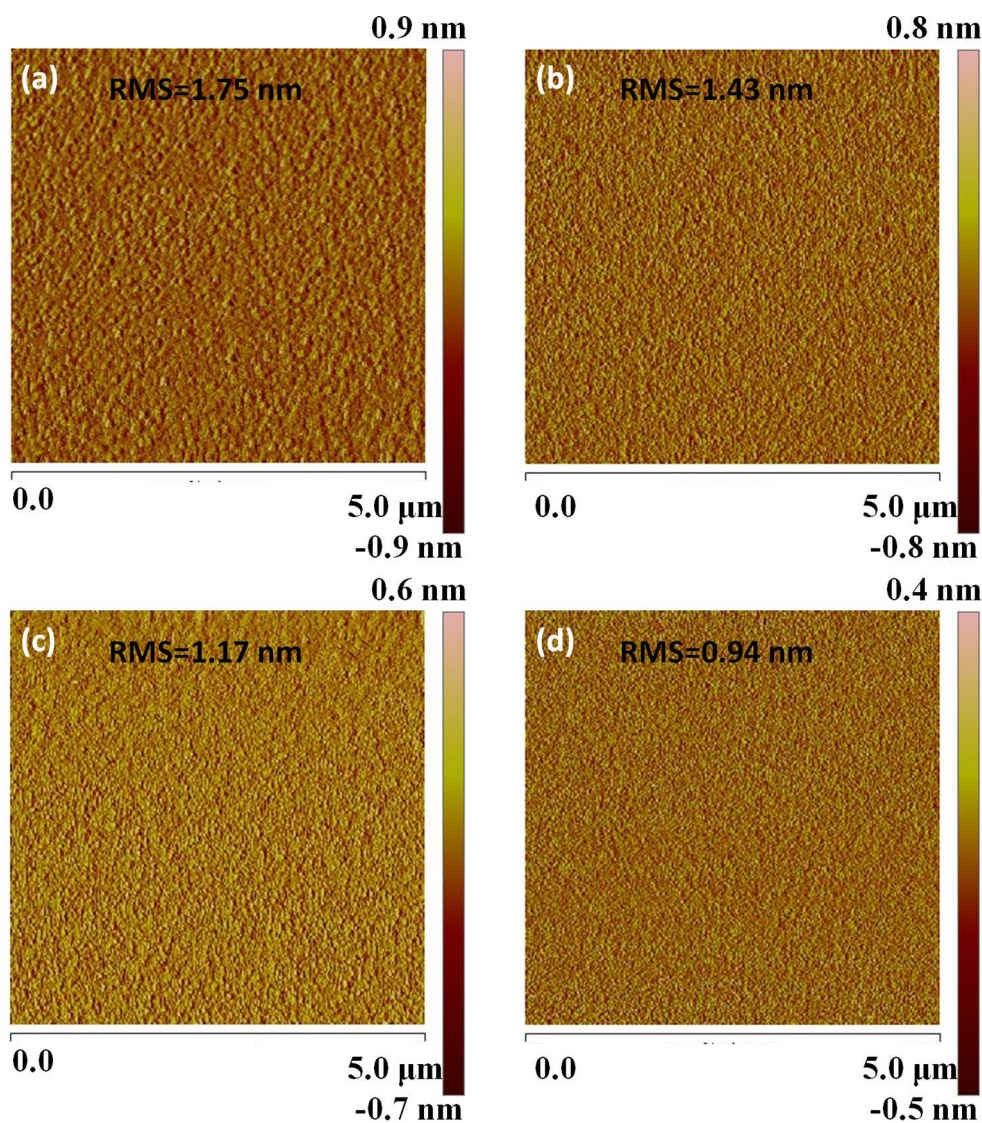


Fig. 7. AFM topography images of (a)  $\text{TiO}_2$ , (b)  $\text{TiO}_2/\text{SAM CQD}$  (1.2 mg/mL), (c)  $\text{TiO}_2/\text{SAM CQD}$  (2.8 mg/mL), and (d)  $\text{TiO}_2/\text{SAM CQD}$  (4.0 mg/mL) films.

In order to investigate the origin of the enhanced  $J_{sc}$  and FF, atomic force microscopy (AFM) was subsequently performed to explore the surface morphologies of the films without or with different kind modification process. Fig. 7a shows AFM images of the  $TiO_2$  film and its surface root-mean square (RMS) roughness is 1.75 nm. After introducing SAM CQD on surface of sol–gel  $TiO_2$  film with different concentration of 1.2, 2.8, and 4.0 mg/mL, the corresponding RMS roughness drops to 1.43 nm (Fig. 7b), 1.17 nm (Fig. 7c), and 0.94 nm (Fig. 7d). The film roughness is negative growth with CQD density. The smoother surface of  $TiO_2$ /CQD would be beneficial to form superior contact between the active layer and EBL, leading to a higher migration rate and a lower charge recombination. The slightly decrease of surface roughness might also increase the physical contact between EBL and the active layer. Additionally, we have checked the morphology of the active layers (PCDTBT:PC<sub>71</sub>BM and P3HT:PC<sub>60</sub>BM) on differently modified  $TiO_2$  buffers, and the results are shown in Figs. S2 (Supporting Information) and S3 (Supporting Information). The different modifications on  $TiO_2$  had little influence on morphology of both two active layers. The active layers on  $TiO_2$  active layers are slightly rougher than active layers on  $TiO_2$  with SAM process, and smoother than the active layers on  $TiO_2$  with CQDs by simply spin-coating.

Afterwards, the shunt resistance ( $R_{sh}$ ) of the control and optimize devices were increased from 2522  $\Omega$  and 4633  $\Omega$  to 21,301  $\Omega$  and 14,569  $\Omega$  for PCDTBT and P3HT based devices (Tables 1 and 2), leading to a progressively increase of FF [57,58]. The presence of the SAM could flatten the peaks on the  $TiO_2$  surface, which did not interfere the active layer coating and reduced the leakage current caused by these peaks [59,60]. Furthermore, the well-pressed underneath film likely causes smaller-scale phase separation of active layer and creates larger-area interfaces where charge separation can take place, contributing to an improved photocurrent and PCE. Though CQD modification with the biggest concentration results in the smoothest surface (Fig. 7d), the PCEs of the corresponding devices exhibit a slight decline for both active layers, which might be induced by the absorption decrease originating from the CQD addition. Generally, there are some protective groups in the surface of solution synthetic QDs materials, and the dielectric protective groups have a negative influence on charge transport, which must be removed before using in OPVs [61]. If there are no protective groups, the stability of the QDs will be decreased, and it is easy to aggregate [62]. As a result, the SAM  $TiO_2$ /CQD layer owns the better surface morphology than the simple spin-coated CQD on  $TiO_2$ . Above all, the smooth surface here suggests that the SAM process help to disperse CQD, suppressing the coverage photo-layer phase segregation beyond the molecular length scale. Not only because the SAM  $TiO_2$ /CQD induces fast electron transfer from polymer film, but also CQD reduces the defect sites density of metal oxide, which reveals potential and possibility for the ameliorate of electron transport property from a SAM  $TiO_2$ /CQD based device.

#### 4. Conclusion

In conclusion, we have successfully developed I-OPVs using SAM  $TiO_2$ /CQD as a cathode interfacial layer, and the excellent electron transport capability of CQD was combined to  $TiO_2$ -based buffer layer device, which exhibited PCEs of 7.33% and 4.42%, significantly outperforming the reference devices by 19.77% and 18.50% for PCDTBT and P3HT system, respectively. The efficiency enhancement is mostly ascribed to the improvement of the photocurrent and substantial increase of FF. The WF of the SAM  $TiO_2$ /CQD layer was intermediate between the bare  $TiO_2$  and LUMO of used acceptor materials, resulted in the decreased energy barrier for electron extraction. Moreover, AFM measurements have also

verified that SAM CQD had a beneficial planarization effect, leading to a closer contact and therefore minimizing the contact resistance at the interface as indicated by the remarkable reduced  $R_s$  and improved  $R_{sh}$  values. Also, the improved morphology and electrical properties of  $TiO_2$ /CQD ETL reduced the interfacial charge recombination and improved FF in the SAM CQD containing devices. These findings about ETL modification by SAM technique provide an easy strategy to fabricate high performance I-OPVs.

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#### Appendix A. Supplementary data

Supplementary data associated with this article can be found, in the online version, at <http://dx.doi.org/10.1016/j.cej.2017.01.067>.

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